

Search Notes

Application/Control No.

09/911,886

Examiner

Shin-Hon Chen

Applicant(s)/Patent under
Reexamination

OKAUE, TAKUMI

Art Unit

2131

SEARCHED

Class	Subclass	Date	Examiner
713	189-193	1/26/2006	S.C.
713	155-158	1/26/2006	S.C.
713	165,176	1/26/2006	S.C.
380	201-203	1/26/2006	S.C.
380	277-282	1/26/2006	S.C.
705	51-57	1/26/2006	S.C.

INTERFERENCE SEARCHED

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713	189-193	1/26/2006	S.C.
713	155-158	1/26/2006	S.C.
713	165,176	1/26/2006	S.C.
380/201-203; 277-282; 705/51-57		1/26/2006	S.C.

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
USPAT, PGPUB, JPO, EPO, DERWENT	1/26/2006	S.C.
Discussed with examiner Longbit Chai	1/25/2006	S.C.